# **Power MOSFET**

## -20 V, -4.1 A, Dual P-Channel ChipFET™

### Features

- Offers an Ultra Low R<sub>DS(ON)</sub> Solution in the ChipFET Package
- Miniature ChipFET Package 40% Smaller Footprint than TSOP-6
- Low Profile (<1.1 mm) Allows it to Fit Easily into Extremely Thin Environments such as Portable Electronics
- Simplifies Circuit Design since Additional Boost Circuits for Gate Voltages are not Required
- Operated at Standard Logic Level Gate Drive, Facilitating Future Migration to Lower Levels using the same Basic Topology
- Pb–Free Package is Available

#### Applications

- Optimized for Battery and Load Management Applications in Portable Equipment such as MP3 Players, Cell Phones, and PDAs
- Charge Control in Battery Chargers
- Buck and Boost Converters

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V	
Gate-to-Source Voltage			V <sub>GS</sub>	± 8.0	V	
Continuous Drain	Stoody State	$T_A = 25^{\circ}C$	I <sub>D</sub>	-2.9	A	
Current (Note 1)	Steady State	$T_A = 85^{\circ}C$		-2.1		
	t ≤ 10 s	$T_A = 25^{\circ}C$		-4.1		
Power Dissipation (Note 1)	Steady State	T 25°C	PD	1.1	W	
	t ≤ 10 s	T <sub>A</sub> = 25°C		2.1		
Pulsed Drain Current	tp = 10	I <sub>DM</sub>	-13.8	A		
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C	
Source Current (Body Diode)			۱ <sub>S</sub>	-1.1	А	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient, Steady State (Note 1)	5	113	°C/W
Junction-to-Ambient, $t \le 10s$ (Note 1)	$R_{\theta JA}$	60	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

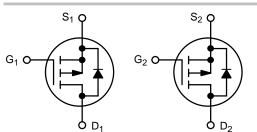
1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)



## **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	V <sub>(BR)DSS</sub> R <sub>DS(ON)</sub> TYP	
	64 mΩ @ –4.5 V	
–20 V	85 mΩ @ –2.5 V	–4.1 A
	120 mΩ @ –1.8 V	

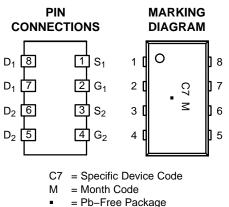


P-Channel MOSFET

P-Channel MOSFET







#### = = 1 b=1 lee 1 ackage

#### ORDERING INFORMATION

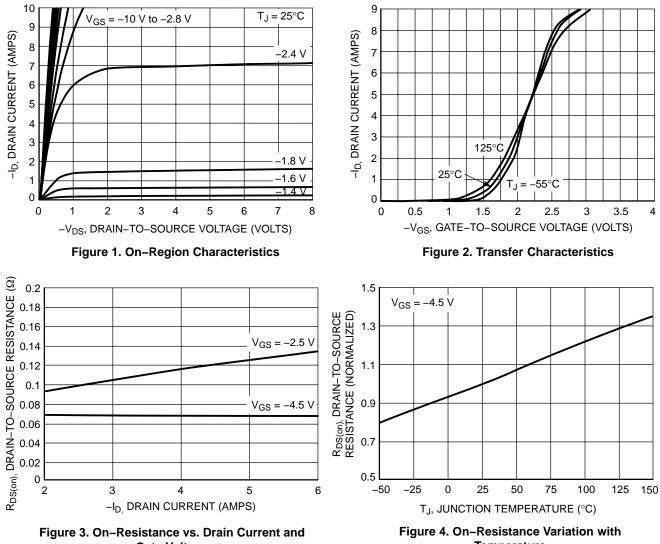
Device	Package	Shipping <sup>†</sup>		
NTHD4102PT1	ChipFET	3000/Tape & Reel		
NTHD4102PT1G	ChipFET (Pb–Free)	3000/Tape & Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

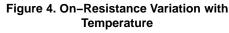
Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(Br)DSS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(Br)DSS/</sub> T <sub>J</sub>			-15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ $T_J = 25^{\circ}C$			-1.0	μΑ
		$ \begin{array}{c} V_{GS} = \ 0 \ V \\ V_{DS} = -16 \ V \\ \end{array} \begin{array}{c} T_{J} = 25^{\circ}C \\ T_{J} = 85^{\circ}C \end{array} $			-5.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 8.0 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 2)		·				
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS, I_D} = -250 \ \mu A$	-0.45		-1.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)/</sub> T <sub>J</sub>			2.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(ON)</sub>	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -2.9 \text{ A}$		64	80	mΩ
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -2.2 \text{ A}$		85	110	
		V <sub>DS</sub> = -1.8 V, I <sub>D</sub> = -1.0 A		120	170	1
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -2.9 \text{ A}$		7.0		S
CHARGES, CAPACITANCES, AND GATE RESI	STANCE	·		•		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz,		750		pF
Output Capacitance	C <sub>OSS</sub>	$V_{\rm DS} = -16 \ \rm V$		100		
Reverse Transfer Capacitance	C <sub>RSS</sub>			45		
Total Gate Charge	Q <sub>G(TOT)</sub>			7.6	8.6	nC
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -16 \text{ V},$ $I_D = -2.6 \text{ A}$		1.3		
Gate-to-Drain Charge	Q <sub>GD</sub>			2.6		
SWITCHING CHARACTERISTICS (Note 3)		·		•		
Turn–On Delay Time	t <sub>d(ON)</sub>			5.5	10	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> = -16 V,		12	25	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -2.6 \text{ A}, \text{R}_G = 2.0 \Omega$		32	40	
Fall Time	t <sub>f</sub>			23	35	
DRAIN-SOURCE DIODE CHARACTERISTICS	•	•				•
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, I_{S} = -1.1 A$		-0.8	-1.2	V
Reverse Recovery Time	t <sub>RR</sub>			20	40	ns
Charge Time	ta	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/μs,		15		
Discharge Time	tb	$I_{\rm S} = 1.0 \rm{A}$		5		
Reverse Recovery Charge	Q <sub>RR</sub>	1		0.01		μC

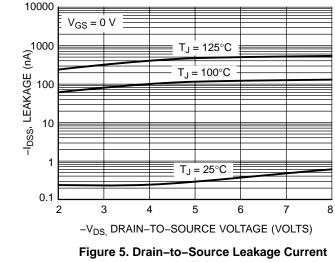
2. Pulse test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2% 3. Switching characteristics are independent of operating junction temperatures



#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

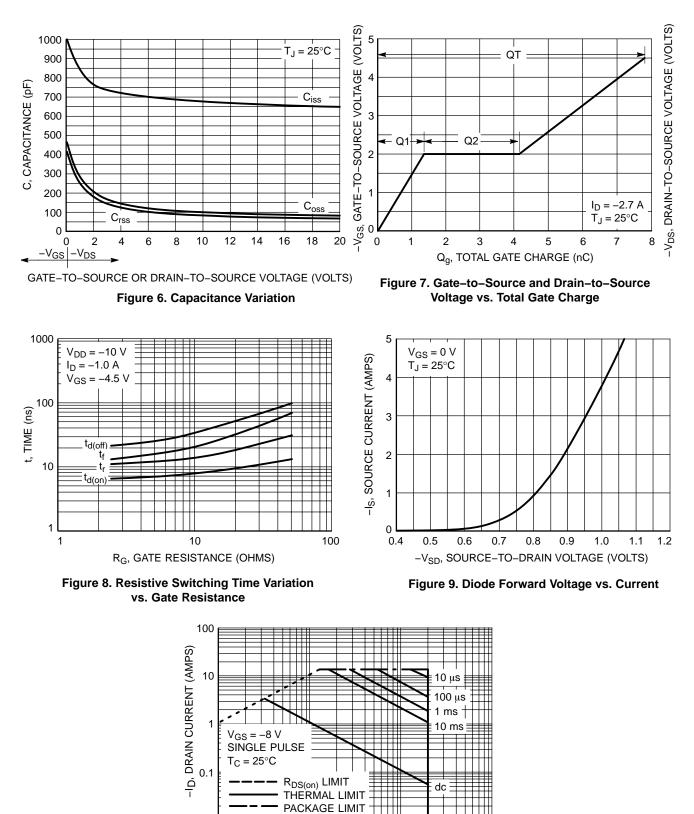
**Gate Voltage** 

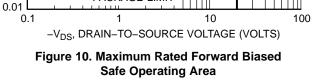




vs. Voltage

#### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

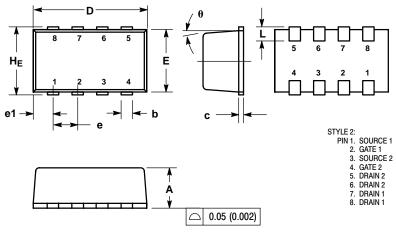




http://onsemi.com 4

#### PACKAGE DIMENSIONS

#### ChipFET ™ CASE 1206A-03 ISSUE G



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER. 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE. 4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM. 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS. 6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	м	ILLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.55	1.65	1.70	0.061	0.065	0.067	
e 0.65 BSC				0.025 BSC			
e1	1 0.55 BSC			0.022 BSC			
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM			5° NOM			

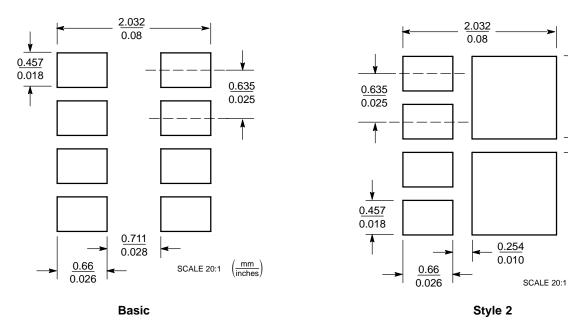
1.092

0.043

<u>0.178</u> 0.007

 $\left(\frac{mm}{inches}\right)$ 

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### ChipFET is a trademark of Vishay Siliconix.

ON Semiconductor and 💷 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death Associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082-1312 USA Phone: 480-829-7710 or 800-344-3860 Toll Free USA/Canada Japan: ON Semiconductor, Japan Customer Focus Center Fax: 480-829-7709 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051 Phone: 81-3-5773-3850

ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.